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#### Applications of "<u>Embedded -</u> <u>Microcontrollers</u>"

#### Details

Product Status	Active
Core Processor	S12Z
Core Size	16-Bit
Speed	32MHz
Connectivity	CANbus, I <sup>2</sup> C, SCI, SPI
Peripherals	DMA, POR, PWM, WDT
Number of I/O	28
Program Memory Size	96KB (96K x 8)
Program Memory Type	FLASH
EEPROM Size	2K x 8
RAM Size	8K x 8
Voltage - Supply (Vcc/Vdd)	3.5V ~ 40V
Data Converters	A/D 10x10b; D/A 1x8b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 125°C (TA)
Mounting Type	Surface Mount
Package / Case	48-LQFP
Supplier Device Package	48-LQFP (7x7)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/s912zvc96f0mlfr

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

Priority	Source	Action
Highest	TRIG	Force immediately to final state
	DBGEEV	Force to next state as defined by state control registers (EEVE=2'b10)
	Match3	Force to next state as defined by state control registers
	Match1	Force to next state as defined by state control registers
Lowest	Match0	Force to next state as defined by state control registers

#### Table 6-31. Event Priorities

## 6.4.4 State Sequence Control



Figure 6-19. State Sequencer Diagram

The state sequencer allows a defined sequence of events to provide a breakpoint. When the DBG module is armed by setting the ARM bit in the DBGC1 register, the state sequencer enters State1. Further transitions between the states are controlled by the state control registers and depend upon event occurrences (see Section 6.4.3, "Events). From Final State the only permitted transition is back to the disarmed State0. Transition between the states 1 to 3 is not restricted. Each transition updates the SSF[2:0] flags in DBGSR accordingly to indicate the current state. If breakpoints are enabled, then an event based transition to State0 generates the breakpoint request. A transition to State0 resulting from writing "0" to the ARM bit does not generate a breakpoint request.

## 6.4.4.1 Final State

When the Final State is reached the state sequencer returns to State0 immediately and the debug module is disarmed. If breakpoints are enabled, a breakpoint request is generated on transitions to State0.

## 6.4.5 Breakpoints

Breakpoints can be generated by state sequencer transitions to State0. Transitions to State0 are forced by the following events

# Chapter 8 S12 Clock, Reset and Power Management Unit (S12CPMU\_UHV\_V7)

## **Revision History**

Rev. No. (Item No)	Date (Submitted By)	Sections Affected	Substantial Change(s)
V07.00	6 March 2013		<ul><li> copied from V5</li><li> adapted for Hearst: added VDDC, added EXTCON Bit</li></ul>
V07.01	13 June 2013		<ul><li>EXTCON register Bit: correct reset value to 1</li><li>PMRF register Bit: corrected description</li></ul>
V07.02	21 Aug. 2013		<ul> <li>correct bit numbering for CSAD Bit</li> <li>f<sub>PLLRST</sub> changed to f<sub>VCORST</sub></li> <li>changed frequency upper limit of external Pierce Oscillator (XOSCLCP) from 16MHz to 20MHz</li> <li>corrected typo in heading of CPMUOSC2 Field Description</li> <li>Memory Map, CPMUAPIRH register: corrected address typo</li> </ul>

## 8.1 Introduction

This specification describes the function of the Clock, Reset and Power Management Unit (S12CPMU\_UHV\_V7).

- The Pierce oscillator (XOSCLCP) provides a robust, low-noise and low-power external clock source. It is designed for optimal start-up margin with typical crystal oscillators.
- The Voltage regulator (VREGAUTO) operates from the range 6V to 18V. It provides all the required chip internal voltages and voltage monitors.
- The Phase Locked Loop (PLL) provides a highly accurate frequency multiplier with internal filter.
- The Internal Reference Clock (IRC1M) provides a 1MHz internal clock.

## 8.1.1 Features

The Pierce Oscillator (XOSCLCP) contains circuitry to dynamically control current gain in the output amplitude. This ensures a signal with low harmonic distortion, low power and good noise immunity.

- Supports crystals or resonators from 4MHz to 20MHz.
- High noise immunity due to input hysteresis and spike filtering.
- Low RF emissions with peak-to-peak swing limited dynamically
- Transconductance (gm) sized for optimum start-up margin for typical crystals
- Dynamic gain control eliminates the need for external current limiting resistor
- Integrated resistor eliminates the need for external bias resistor
- Low power consumption: Operates from internal 1.8V (nominal) supply, Amplitude control limits power
- Optional oscillator clock monitor reset
- Optional full swing mode for higher immunity against noise injection on the cost of higher power consumption and increased emission

The Voltage Regulator (VREGAUTO) has the following features:

- Input voltage range from 6 to 18V (nominal operating range)
- Low-voltage detect (LVD) with low-voltage interrupt (LVI)
- Power-on reset (POR)
- Low-voltage reset (LVR)
- On Chip Temperature Sensor and Bandgap Voltage measurement via internal ADC channel.
- Voltage Regulator providing Full Performance Mode (FPM) and Reduced Performance Mode (RPM)
- External ballast device support to reduce internal power dissipation
- Capable of supplying both the MCU internally plus external components
- Over-temperature interrupt

The Phase Locked Loop (PLL) has the following features:

- Highly accurate and phase locked frequency multiplier
- Configurable internal filter for best stability and lock time
- Frequency modulation for defined jitter and reduced emission
- Automatic frequency lock detector
- Interrupt request on entry or exit from locked condition
- PLL clock monitor reset
- Reference clock either external (crystal) or internal square wave (1MHz IRC1M) based.
- PLL stability is sufficient for LIN communication in slave mode, even if using IRC1M as reference clock

The Internal Reference Clock (IRC1M) has the following features:

Field	Description
5 VSEL	<ul> <li>Voltage Access Select Bit — If set, the bandgap reference voltage V<sub>BG</sub> can be accessed internally (i.e. multiplexed to an internal Analog to Digital Converter channel). If not set, the die temperature proportional voltage V<sub>HT</sub> of the temperature sensor can be accessed internally. See device level specification for connectivity. For any of these access the HTE bit must be set.</li> <li>0 An internal temperature proportional voltage V<sub>HT</sub> can be accessed internally.</li> <li>1 Bandgap reference voltage V<sub>BG</sub> can be accessed internally.</li> </ul>
3 HTE	<ul> <li>High Temperature Sensor/Bandgap Voltage Enable Bit — This bit enables the high temperature sensor and bandgap voltage amplifier.</li> <li>0 The temperature sensor and bandgap voltage amplifier is disabled.</li> <li>1 The temperature sensor and bandgap voltage amplifier is enabled.</li> </ul>
2 HTDS	<ul> <li>High Temperature Detect Status Bit — This read-only status bit reflects the temperature status. Writes have no effect.</li> <li>Junction Temperature is below level T<sub>HTID</sub> or RPM.</li> <li>Junction Temperature is above level T<sub>HTIA</sub> and FPM.</li> </ul>
1 HTIE	High Temperature Interrupt Enable Bit         0 Interrupt request is disabled.         1 Interrupt will be requested whenever HTIF is set.
0 HTIF	<ul> <li>High Temperature Interrupt Flag — HTIF is set to 1 when HTDS status bit changes. This flag can only be cleared by writing a 1.</li> <li>Writing a 0 has no effect. If enabled (HTIE=1), HTIF causes an interrupt request.</li> <li>0 No change in HTDS bit.</li> <li>1 HTDS bit has changed.</li> </ul>

#### Table 8-16. CPMUHTCTL Field Descriptions

#### Figure 8-18. Voltage Access Select



# 9.4 Memory Map and Register Definition

This section provides a detailed description of all registers accessible in the ADC12B\_LBA.

## 9.4.1 Module Memory Map

Figure 9-3 gives an overview of all ADC12B\_LBA registers.

### NOTE

Register Address = Base Address + Address Offset, where the Base Address is defined at the MCU level and the Address Offset is defined at the module level.

Address	Name		Bit 7	6	5	4	3	2	1	Bit 0	
0x0000	ADCCTL_0	R W	ADC_EN	ADC_SR	FRZ_MOD	SWAI	ACC_C	CFG[1:0]	STR_SEQA	MOD_CFG	
0x0001	ADCCTL 1	R	CSL_BMO	RVL_BMO	SMOD_AC	AUT_RST	0	0	0	0	
0X0001	ADCCIL_I	W	D	D	С	А					
0x0002	ADCSTS	R	CSL_SEL	RVL_SEL	DBECC_ER R	Reserved	READY	0	0	0	
		W	0								
0x0003	ADCTIM	R W	0				PRS[6:0]				
0x0004	ADCFMT	R	DIM	0	0	0	0		SRES[2:0]		
0.0001	in crimin	W	Duin				-		SILES[2:0]		
0x0005	ADCFLWCTL	R	SEQA	TRIG	RSTA	LDOK	0	0	0	0	
		W D								0	
0x0006	ADCEIE	W	IA_EIE	CMD_EIE	EOL_EIE	Reserved	TRIG_EIE	RSTAR_EIE	LDOK_EIE	0	
o ooo <b>-</b>		R		CONIF OI	<b>D</b> 1	0	0	0	0	0	
0x0007	ADCIE	W	SEQAD_IE	E	Reserved						
0x0008	ADCEIE	R	IA FIF	CMD FIF	FOL FIF	Reserved	TRIG FIF	RSTAR FIF	I DOK FIF	0	
0.00000	<i>HD</i> CEII	W	<u>_</u> En	CMD_En	LOF_TH	Reserved	Indo_En	Konne_En	EDOK_EN		
0x0009	ADCIF	R	SEQAD_IF	CONIF_OI	Reserved	0	0	0	0	0	
		W D		F							
0x000A	ADCCONIE_0	W				CON	_IE[15:8]				
0x000B	ADCCONIE_1	R W				CON_IE[7:1	]			EOL_IE	
0x000C	ADCCONIF_0	R W				CON	_IF[15:8]				
		R									
0x000D	ADCCONIF_1	W				CON_IF[7:1	]			EOL_IF	
0x000E	ADCIMDRI_0	R	CSL_IMD	RVL_IMD	0	0	0	0	0	0	
			R	0	0			RIDX	IMD[5:0]		
0x000F	ADCIMDRI_1	W	0	0			KIDA_	[2.0]			
				1							
				= Unimplem	ented or Reser	ved					

Figure 9-3. ADC12B\_LBA Register Summary (Sheet 1 of 3)

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Table 9-2. ADCCTL	0 Field Descriptions (	(continued)
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Field	Description
11-10 ACC_CFG[1: 0]	<b>ADCFLWCTL Register Access Configuration</b> — These bits define if the register ADCFLWCTL is controlled via internal interface only or data bus only or both. See Table 9-3. for more details.
9	Control Of Conversion Result Storage and RSTAR_EIF flag setting at Sequence Abort or Restart Event — This bit
STR_SEQA	controls conversion result storage and RSTAR_EIF flag setting when a Sequence Abort Event or Restart Event occurs as follows:
	<ul> <li>If SIR_SEQA = 1 b0 and if a:</li> <li>Sequence Abort Event or Restart Event is issued during a conversion the data of this conversion is not stored and the respective conversion complete flag is not set</li> </ul>
	• Restart Event only is issued before the last conversion of a CSL is finished and no Sequence Abort Event is in process (SEQA clear) causes the RSTA_EIF error flag to be asserted and bit SEQA gets set by hardware
	If $STR\_SEQA = 1$ 'b1 and if a:
	• Sequence Abort Event or Restart Event is issued during a conversion the data of this conversion is stored and the respective conversion complete flag is set and Intermediate Result Information Register is undated
	<ul> <li>Restart Event only occurs during the last conversion of a CSL and no Sequence Abort Event is in process (SEQA clear) does not set the RSTA_EIF error flag</li> </ul>
	• Restart Event only is issued before the CSL is finished and no Sequence Abort Event is in process (SEQA clear) causes the RSTA_EIF error flag to be asserted and bit SEQA gets set by hardware
8	(Conversion Flow Control) Mode Configuration — This bit defines the conversion flow control after a Restart Event and
MOD_CFG	after execution of the "End Of List" command type:
	- Restart Mode
	(For more details please see also section Section 9.5.3.2, "Introduction of the Programmer's Model and following.)
	0 "Restart Mode" selected.
	1 "Trigger Mode" selected.

ACC_CFG[1]	ACC_CFG[0]	ADCFLWCTL Access Mode
0	0	None of the access paths is enabled (default / reset configuration)
0	1	Single Access Mode - Internal Interface (ADCFLWCTL access via internal interface only)
1	0	Single Access Mode - Data Bus (ADCFLWCTL access via data bus only)
1	1	Dual Access Mode (ADCFLWCTL register access via internal interface and data bus)

#### Table 9-3. ADCFLWCTL Register Access Configurations

### NOTE

Each conversion flow control bit (SEQA, RSTA, TRIG, LDOK) must be controlled by software or internal interface according to the requirements described in Section 9.5.3.2.4, "The two conversion flow control Mode Configurations and overview summary in Table 9-10.

## 9.4.2.13 ADC Intermediate Result Information Register (ADCIMDRI)

This register is cleared when bit ADC\_SR is set or bit ADC\_EN is clear.

Module Base + 0x000E



#### Figure 9-16. ADC Intermediate Result Information Register (ADCIMDRI)

Read: Anytime

Write: Never

Field	Description
15 CSL_IMD	<ul> <li>Active CSL At Intermediate Event — This bit indicates the active (used) CSL at the occurrence of a conversion interrupt flag (CON_IF[15:1]) (occurrence of an intermediate result buffer fill event) or when a Sequence Abort Event gets executed.</li> <li>0 CSL_0 active (used) when a conversion interrupt flag (CON_IF[15:1]) got set.</li> <li>1 CSL_1 active (used) when a conversion interrupt flag (CON_IF[15:1]) got set.</li> </ul>
14 RVL_IMD	<ul> <li>Active RVL At Intermediate Event — This bit indicates the active (used) RVL buffer at the occurrence of a conversion interrupt flag (CON_IF[15:1]) (occurrence of an intermediate result buffer fill event) or when a Sequence Abort Event gets executed.</li> <li>0 RVL_0 active (used) when a conversion interrupt flag (CON_IF[15:1]) got set.</li> <li>1 RVL_1 active (used) when a conversion interrupt flag (CON_IF[15:1]) got set.</li> </ul>
5-0 RIDX_IMD[5 :0]	<b>RES_IDX Value At Intermediate Event</b> — These bits indicate the result index (RES_IDX) value at the occurrence of a conversion interrupt flag (CON_IF[15:1]) (occurrence of an intermediate result buffer fill event) or occurrence of EOL_IF flag or when a Sequence Abort Event gets executed to abort an ongoing conversion (the result index RES_IDX is captured at the occurrence of a result data store).
	<ul> <li>When a Sequence Abort Event has been processed flag SEQAD_IF is set and the RES_IDX value of the last stored result is provided. Hence in case an ongoing conversion is aborted the RES_IDX value captured in RIDX_IMD bits depends on bit STORE_SEQA:</li> <li>STORE_SEQA =1: The result index of the aborted conversion is provided</li> <li>STORE_SEQA =0: The result index of the last stored result at abort execution time is provided In case a CSL is aborted while no conversion is ongoing (ADC waiting for a Trigger Event) the last captured result index is provided.</li> <li>In case a Sequence Abort Event was initiated by hardware due to MCU entering Stop Mode or Wait Mode with bit SWAI set. the result index of the last stored result is captured by bits RIDX_IMD but flag SEOAD_IF is not set.</li> </ul>

#### Table 9-17. ADCIMDRI Field Descriptions

### NOTE

The register ADCIMDRI is updated and simultaneously a conversion interrupt flag CON\_IF[15:1] occurs when the corresponding conversion command (conversion command with INTFLG\_SEL[3:0] set) has been processed and related data has been stored to RAM.

# 10.3.2.2 BATS Module Status Register (BATSR)



Figure 10-4. BATS Module Status Register (BATSR)

<sup>1</sup> Read: Anytime Write: Never

Field	Description
1 BVHC	<b>BATS Voltage Sense High Condition Bit</b> — This status bit indicates that a high voltage at VSUP, depending on selection, is present.
	$\begin{array}{l} 0 \ V_{measured} < V_{HBI\_A} \ (rising \ edge) \ or \ V_{measured} < V_{HBI\_D} \ (falling \ edge) \\ 1 \ V_{measured} \ge V_{HBI\_A} \ (rising \ edge) \ or \ V_{measured} \ge V_{HBI\_D} \ (falling \ edge) \end{array}$
0 BVLC	<b>BATS Voltage Sense Low Condition Bit</b> — This status bit indicates that a low voltage at VSUP, depending on selection, is present.
	$\begin{array}{l} 0 \ V_{measured} \geq V_{LBI\_A} \ (falling \ edge) \ or \ V_{measured} \geq V_{LBI\_D} \ (rising \ edge) \\ 1 \ V_{measured} < V_{LBI\_A} \ (falling \ edge) \ or \ V_{measured} < V_{LBI\_D} \ (rising \ edge) \end{array}$

#### Table 10-3. BATSR - Register Field Descriptions

#### Figure 10-5. BATS Voltage Sensing



Chapter 11 Timer Module (TIM16B8CV3) Block Description

## 11.3.2.15 16-Bit Pulse Accumulator Control Register (PACTL)

Module Base + 0x0020





### Read: Any time

Write: Any time

When PAEN is set, the Pulse Accumulator counter is enabled. The Pulse Accumulator counter shares the input pin with IOC7.

Field	Description
6 PAEN	<ul> <li>Pulse Accumulator System Enable — PAEN is independent from TEN. With timer disabled, the pulse accumulator can function unless pulse accumulator is disabled.</li> <li>0 16-Bit Pulse Accumulator system disabled.</li> <li>1 Pulse Accumulator system enabled.</li> </ul>
5 PAMOD	<ul> <li>Pulse Accumulator Mode — This bit is active only when the Pulse Accumulator is enabled (PAEN = 1). See Table 11-19.</li> <li>0 Event counter mode.</li> <li>1 Gated time accumulation mode.</li> </ul>
4 PEDGE	<ul> <li>Pulse Accumulator Edge Control — This bit is active only when the Pulse Accumulator is enabled (PAEN = 1).</li> <li>For PAMOD bit = 0 (event counter mode). See Table 11-19.</li> <li>0 Falling edges on IOC7 pin cause the count to be increased.</li> <li>1 Rising edges on IOC7 pin cause the count to be increased.</li> <li>For PAMOD bit = 1 (gated time accumulation mode).</li> <li>0 IOC7 input pin high enables M (Bus clock) divided by 64 clock to Pulse Accumulator and the trailing falling edge on IOC7 sets the PAIF flag.</li> <li>1 IOC7 input pin low enables M (Bus clock) divided by 64 clock to Pulse Accumulator and the trailing rising edge on IOC7 sets the PAIF flag.</li> </ul>
3:2 CLK[1:0]	Clock Select Bits — Refer to Table 11-20.
1 PAOVI	Pulse Accumulator Overflow Interrupt Enable         0 Interrupt inhibited.         1 Interrupt requested if PAOVF is set.
0 PAI	Pulse Accumulator Input Interrupt Enable         0 Interrupt inhibited.         1 Interrupt requested if PAIF is set.

Table 12-4. TSCR	Field Descriptions
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Field	Description
7 TEN	Timer Enable         0 Disables the main timer, including the counter. Can be used for reducing power consumption.         1 Allows the timer to function normally.         If for any reason the timer is not active, there is no ÷64 clock for the pulse accumulator because the ÷64 is generated by the timer prescaler.
6 TSWAI	<ul> <li>Timer Module Stops While in Wait</li> <li>Allows the timer module to continue running during wait.</li> <li>Disables the timer module when the MCU is in the wait mode. Timer interrupts cannot be used to get the MCU out of wait.</li> <li>TSWAI also affects pulse accumulator.</li> </ul>
5 TSFRZ	Timer Stops While in Freeze Mode         0       Allows the timer counter to continue running while in freeze mode.         1       Disables the timer counter whenever the MCU is in freeze mode. This is useful for emulation.         TSFRZ does not stop the pulse accumulator.
4 TFFCA	<ul> <li>Timer Fast Flag Clear All</li> <li>Allows the timer flag clearing to function normally.</li> <li>For TFLG1(0x000E), a read from an input capture or a write to the output compare channel (0x0010–0x001F) causes the corresponding channel flag, CnF, to be cleared. For TFLG2 (0x000F), any access to the TCNT register (0x0004, 0x0005) clears the TOF flag. This has the advantage of eliminating software overhead in a separate clear sequence. Extra care is required to avoid accidental flag clearing due to unintended accesses.</li> </ul>
3 PRNT	Precision Timer0Enables legacy timer. PR0, PR1, and PR2 bits of the TSCR2 register are used for timer counter prescaler selection.1Enables precision timer. All bits of the PTPSR register are used for Precision Timer Prescaler Selection, and all bits.This bit is writable only once out of reset.

## 12.3.2.5 Timer Toggle On Overflow Register 1 (TTOV)

Module Base + 0x0007

	7	6	5	4	3	2	1	0
R W	RESERVED	RESERVED	RESERVED	RESERVED	TOV3	TOV2	TOV1	TOV0
Reset	0	0	0	0	0	0	0	0

ī.

### Figure 12-9. Timer Toggle On Overflow Register 1 (TTOV)

Read: Anytime

Write: Anytime

Chapter 15 Serial Peripheral Interface (S12SPIV5)

## 15.3.2.3 SPI Baud Rate Register (SPIBR)

Module Base +0x0002



#### Figure 15-5. SPI Baud Rate Register (SPIBR)

#### Read: Anytime

Write: Anytime; writes to the reserved bits have no effect

#### Table 15-5. SPIBR Field Descriptions

Field	Description
6–4 SPPR[2:0]	<b>SPI Baud Rate Preselection Bits</b> — These bits specify the SPI baud rates as shown in Table 15-6. In master mode, a change of these bits will abort a transmission in progress and force the SPI system into idle state.
2–0 SPR[2:0]	<b>SPI Baud Rate Selection Bits</b> — These bits specify the SPI baud rates as shown in Table 15-6. In master mode, a change of these bits will abort a transmission in progress and force the SPI system into idle state.

The baud rate divisor equation is as follows:

The baud rate can be calculated with the following equation:

Baud Rate = BusClock / BaudRateDivisor

Eqn. 15-2

#### NOTE

For maximum allowed baud rates, please refer to the SPI Electrical Specification in the Electricals chapter of this data sheet.

SPPR2	SPPR1	SPPR0	SPR2	SPR1	SPR0	Baud Rate Divisor	Baud Rate
0	0	0	0	0	0	2	12.5 Mbit/s
0	0	0	0	0	1	4	6.25 Mbit/s
0	0	0	0	1	0	8	3.125 Mbit/s
0	0	0	0	1	1	16	1.5625 Mbit/s
0	0	0	1	0	0	32	781.25 kbit/s
0	0	0	1	0	1	64	390.63 kbit/s
0	0	0	1	1	0	128	195.31 kbit/s
0	0	0	1	1	1	256	97.66 kbit/s
0	0	1	0	0	0	4	6.25 Mbit/s
0	0	1	0	0	1	8	3.125 Mbit/s

# 17.4 Memory Map and Register Definition

This section provides a detailed description of all registers accessible in the CAN Physical Layer.

# 17.4.1 Module Memory Map

A summary of the registers associated with the CAN Physical Layer sub-block is shown in Table 17-3. Detailed descriptions of the registers and bits are given in the following sections.

### NOTE

Register Address = Module Base Address + Address Offset, where the Module Base Address is defined at the MCU level and the Address Offset is defined at the module level.

Address Offset	Register Name		Bit 7	6	5	4	3	2	1	Bit 0
0.20000	CDDD	R	CPDR7	0	0	0	0	0		CPDR0
0X0000	UNUUUU CIDR	W							CIDKI	
0x0001	CPCR	R W	CPE	SPE	WUP	PE1-0	0		SLR2-0	
0x0002	Reserved	R W	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved
00002	CDCD	R	CPCHVH	CPCHVL	CPCLVH	CPCLVL	CPDT	0	0	0
0x0003 CPSR	CPSK	W								
0x0004	Reserved	R W	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved
0x0005	Reserved	R W	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved
00006	CDIE	R	0	0	0	CDVEIE	CDDTIE	0	0	CROCIE
0x0000	CFIE	W				CPVFIE CPDTIE	CPDTIE		CPOCIE	
0x0007	CPIF	R W	CHVHIF	CHVLIF	CLVHIF	CLVLIF	CPDTIF	0	CHOCIF	CLOCIF
		[		= Unimplemented or Reserved						

Table 17-3. CAN Physical Layer Register Summary

# Chapter 18 Scalable Controller Area Network (S12MSCANV3)

## **Revision History**

Revision Number	<b>Revision Date</b>	Sections Affected	Description of Changes
V03.14	12 Nov 2012	Table 18-10	Corrected RxWRN and TxWRN threshold values
V03.15	12 Jan 2013	Table 18-2 Table 18-25 Figure 18-37 18.1/18-549 18.3.2.15/18-570	<ul> <li>Updated TIME bit description</li> <li>Added register names to buffer map</li> <li>Updated TSRH and TSRL read conditions</li> <li>Updated introduction</li> <li>Updated CANTXERR and CANRXERR register notes</li> </ul>
V03.16	08 Aug 2013		Corrected typos

# **18.1** Introduction

NXP's scalable controller area network (S12MSCANV3) definition is based on the MSCAN12 definition, which is the specific implementation of the MSCAN concept targeted for the S12, S12X and S12Z microcontroller families.

The module is a communication controller implementing the CAN 2.0A/B protocol as defined in the Bosch specification dated September 1991. For users to fully understand the MSCAN specification, it is recommended that the Bosch specification be read first to familiarize the reader with the terms and concepts contained within this document.

Though not exclusively intended for automotive applications, CAN protocol is designed to meet the specific requirements of a vehicle serial data bus: real-time processing, reliable operation in the EMI environment of a vehicle, cost-effectiveness, and required bandwidth.

MSCAN uses an advanced buffer arrangement resulting in predictable real-time behavior and simplified application software.

Chapter 18 Scalable Controller Area Network (S12MSCANV3)

Register Name		Bit 7	6	5	4	3	2	1	Bit 0
0x0000 CANCTL0	R W	RXFRM	RXACT	CSWAI	SYNCH	TIME	WUPE	SLPRQ	INITRQ
0x0001 CANCTL1	R W	CANE	CLKSRC	LOOPB	LISTEN	BORM	WUPM	SLPAK	INITAK
0x0002 CANBTR0	R W	SJW1	SJW0	BRP5	BRP4	BRP3	BRP2	BRP1	BRP0
0x0003 CANBTR1	R W	SAMP	TSEG22	TSEG21	TSEG20	TSEG13	TSEG12	TSEG11	TSEG10
0x0004 CANRFLG	R W	WUPIF	CSCIF	RSTAT1	RSTAT0	TSTAT1	TSTAT0	OVRIF	RXF
0x0005 CANRIER	R W	WUPIE	CSCIE	RSTATE1	RSTATE0	TSTATE1	TSTATE0	OVRIE	RXFIE
0x0006 CANTFLG	R W	0	0	0	0	0	TXE2	TXE1	TXE0
0x0007 CANTIER	R W	0	0	0	0	0	TXEIE2	TXEIE1	TXEIE0
0x0008 CANTARQ	R W	0	0	0	0	0	ABTRQ2	ABTRQ1	ABTRQ0
0x0009 CANTAAK	R W	0	0	0	0	0	ABTAK2	ABTAK1	ABTAK0
0x000A CANTBSEL	R W	0	0	0	0	0	TX2	TX1	TX0
0x000B CANIDAC	R W	0	0	IDAM1	IDAM0	0	IDHIT2	IDHIT1	IDHIT0
0x000C Reserved	R W	0	0	0	0	0	0	0	0
0x000D CANMISC	R W	0	0	0	0	0	0	0	BOHOLD
0x000E CANRXERR	R W	RXERR7	RXERR6	RXERR5	RXERR4	RXERR3	RXERR2	RXERR1	RXERR0

= Unimplemented or Reserved

Figure 18-3. MSCAN Register Summary

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Chapter 18 Scalable Controller Area Network (S12MSCANV3)

The MSCAN facilitates a sophisticated message storage system which addresses the requirements of a broad range of network applications.

## 18.4.2.1 Message Transmit Background

Modern application layer software is built upon two fundamental assumptions:

- Any CAN node is able to send out a stream of scheduled messages without releasing the CAN bus between the two messages. Such nodes arbitrate for the CAN bus immediately after sending the previous message and only release the CAN bus in case of lost arbitration.
- The internal message queue within any CAN node is organized such that the highest priority message is sent out first, if more than one message is ready to be sent.

The behavior described in the bullets above cannot be achieved with a single transmit buffer. That buffer must be reloaded immediately after the previous message is sent. This loading process lasts a finite amount of time and must be completed within the inter-frame sequence (IFS) to be able to send an uninterrupted stream of messages. Even if this is feasible for limited CAN bus speeds, it requires that the CPU reacts with short latencies to the transmit interrupt.

A double buffer scheme de-couples the reloading of the transmit buffer from the actual message sending and, therefore, reduces the reactiveness requirements of the CPU. Problems can arise if the sending of a message is finished while the CPU re-loads the second buffer. No buffer would then be ready for transmission, and the CAN bus would be released.

At least three transmit buffers are required to meet the first of the above requirements under all circumstances. The MSCAN has three transmit buffers.

The second requirement calls for some sort of internal prioritization which the MSCAN implements with the "local priority" concept described in Section 18.4.2.2, "Transmit Structures."

## **18.4.2.2** Transmit Structures

The MSCAN triple transmit buffer scheme optimizes real-time performance by allowing multiple messages to be set up in advance. The three buffers are arranged as shown in Figure 18-39.

All three buffers have a 13-byte data structure similar to the outline of the receive buffers (see Section 18.3.3, "Programmer's Model of Message Storage"). An additional Transmit Buffer Priority Register (TBPR) contains an 8-bit local priority field (PRIO) (see Section 18.3.3.4, "Transmit Buffer Priority Register (TBPR)"). The remaining two bytes are used for time stamping of a message, if required (see Section 18.3.3.5, "Time Stamp Register (TSRH–TSRL)").

To transmit a message, the CPU must identify an available transmit buffer, which is indicated by a set transmitter buffer empty (TXEx) flag (see Section 18.3.2.7, "MSCAN Transmitter Flag Register (CANTFLG)"). If a transmit buffer is available, the CPU must set a pointer to this buffer by writing to the CANTBSEL register (see Section 18.3.2.11, "MSCAN Transmit Buffer Selection Register (CANTBSEL)"). This makes the respective buffer accessible within the CANTXFG address space (see Section 18.3.3, "Programmer's Model of Message Storage"). The algorithmic feature associated with the CANTBSEL register simplifies the transmit buffer selection. In addition, this scheme makes the handler

Syntax	Description
SYNC_SEG	System expects transitions to occur on the CAN bus during this period.
Transmit Point	A node in transmit mode transfers a new value to the CAN bus at this point.
Sample Point	A node in receive mode samples the CAN bus at this point. If the three samples per bit option is selected, then this point marks the position of the third sample.

The synchronization jump width (see the Bosch CAN 2.0A/B specification for details) can be programmed in a range of 1 to 4 time quanta by setting the SJW parameter.

The SYNC\_SEG, TSEG1, TSEG2, and SJW parameters are set by programming the MSCAN bus timing registers (CANBTR0, CANBTR1) (see Section 18.3.2.3, "MSCAN Bus Timing Register 0 (CANBTR0)" and Section 18.3.2.4, "MSCAN Bus Timing Register 1 (CANBTR1)").

Table 18-36 gives an overview of the Bosch CAN 2.0A/B specification compliant segment settings and the related parameter values.

#### NOTE

It is the user's responsibility to ensure the bit time settings are in compliance with the CAN standard.

Time Segment 1	TSEG1	Time Segment 2	TSEG2	Synchronization Jump Width	SJW
510	49	2	1	12	01
4 11	310	3	2	13	02
512	411	4	3	14	03
613	512	5	4	1 4	03
714	613	6	5	1 4	03
815	714	7	6	1 4	03
916	815	8	7	1 4	03

Table 18-36. Bosch CAN 2.0A/B Compliant Bit Time Segment Settings

## **18.4.4** Modes of Operation

## **18.4.4.1** Normal System Operating Modes

The MSCAN module behaves as described within this specification in all normal system operating modes. Write restrictions exist for some registers.

The operational amplifier is also stand alone usable.

Figure 19-1 shows the block diagram of the DAC\_8B5V module.

# **19.2.1** Features

The DAC\_8B5V module includes these distinctive features:

- 1 digital-analog converter channel with:
  - 8 bit resolution
  - full and reduced output voltage range
  - buffered or unbuffered analog output voltage usable
- operational amplifier stand alone usable

# **19.2.2** Modes of Operation

The DAC\_8B5V module behaves as follows in the system power modes:

1. CPU run mode

The functionality of the DAC\_8B5V module is available.

2. CPU stop mode

Independent from the mode settings, the operational amplifier is disabled, switch S1 and S2 are open.

If the "Unbuffered DAC" mode was used before entering stop mode, then the DACU pin will reach VRH voltage level during stop mode.

The content of the configuration registers is unchanged.

## NOTE

After enabling and after return from CPU stop mode, the DAC\_8B5V module needs a settling time to get fully operational, see Settling time specification of dac\_8b5V\_analog\_ll18.

# **Appendix A MCU Electrical Specifications**

# **Revision History**

Rev. No. (Item No.)	Date (Submitted By)	Substantial Change(s)
Rev 1.0	19-January-2015	Initial Release for Publication on nxp.com
Rev 1.1	26-March-2018	<ul> <li>Changed footnote 4 of Appendix Table E-1., "Voltage Regulator Electrical Characteristics (Junction Temperature From -40°C To +175°C)</li> <li>All S12ZVC material with 2018 Datecode for work week 23 (1823) and beyond have a fully trimmed ACLK.</li> <li>Shipping label marking is 1823 and beyond</li> <li>Component top side marking is week 23 and beyond</li> <li>See Appendix , "Example Top Side Marking</li> </ul>

# A.1 General

This supplement contains the most accurate electrical information for the MC9S12ZVC-Family available at the time of publication.

## A.1.1 Power Pins

# **Appendix D SPI Electrical Specifications**

This section provides electrical parametrics and ratings for the SPI.

In Figure D-1. the measurement conditions are listed.

Description	Value	Unit		
Drive mode	full drive mode	—		
Load capacitance $C_{LOAD}^{l}$ , on all outputs	50	pF		
Thresholds for delay measurement points	(35% / 65%) VDDX	V		

<sup>1</sup>Timing specified for equal load on all SPI output pins. Avoid asymmetric load.

## D.0.1 Master Mode

In Figure D-2. the timing diagram for master mode with transmission format CPHA=0 is depicted.



Figure D-2. SPI Master Timing (CPHA=0)

In Figure D-3. the timing diagram for master mode with transmission format CPHA=1 is depicted.

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Global Address	Register Name		Bit 7	6	5	4	3	2	1	Bit 0
0x0264	DDRE	R W	0	0	0	0	0	0	DDRE1	DDRE0
0x0265	Reserved	R W	0	0	0	0	0	0	0	0
0x0266	PERE	R W	0	0	0	0	0	0	PERE1	PERE0
0x0267	Reserved	R W	0	0	0	0	0	0	0	0
0x0268	PPSE	R W	0	0	0	0	0	0	PPSE1	PPSE0
0x0269– 0x027F	Reserved	R W	0	0	0	0	0	0	0	0
0x0280	PTADH	R W	PTADH7	PTADH6	PTADH5	PTADH4	PTADH3	PTADH2	PTADH1	PTADH0
0x0281	PTADL	R W	PTADL7	PTADL6	PTADL5	PTADL4	PTADL3	PTADL2	PTADL1	PTADL0
0x0282	PTIADH	R W	PTIADH7	PTIADH6	PTIADH5	PTIADH4	PTIADH3	PTIADH2	PTIADH1	PTIADH0
0x0283	PTIADL	R W	PTIADL7	PTIADL6	PTIADL5	PTIADL4	PTIADL3	PTIADL2	PTIADL1	PTIADL0
0x0284	DDRADH	R W	DDRADH7	DDRADH6	DDRADH5	DDRADH4	DDRADH3	DDRADH2	DDRADH1	DDRADH0
0x0285	DDRADL	R W	DDRADL7	DDRADL6	DDRADL5	DDRADL4	DDRADL3	DDRADL2	DDRADL1	DDRADL0
0x0286	PERADH	R W	PERADH7	PERADH6	PERADH5	PERADH4	PERADH3	PERADH2	PERADH1	PERADH0
0x0287	PERADL	R W	PERADL7	PERADL6	PERADL5	PERADL4	PERADL3	PERADL2	PERADL1	PERADL0
0x0288	PPSADH	R W	PPSADH7	PPSADH6	PPSADH5	PPSADH4	PPSADH3	PPSADH2	PPSADH1	PPSADH0
0x0289	PPSADL	R W	PPSADL7	PPSADL6	PPSADL5	PPSADL4	PPSADL3	PPSADL2	PPSADL1	PPSADL0

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